

FUNCTION TABLE
 (each latch)

INPUTS		OUTPUTS	
D	C	Q	\bar{Q}
L	H	L	H
H	H	H	L
X	L	Q_0	\bar{Q}_0

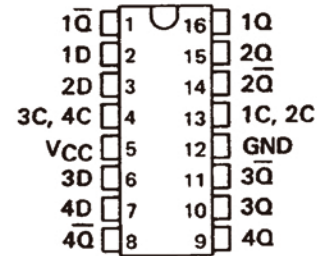
H = high level, L = low level, X = irrelevant
 Q_0 = the level of Q before the high-to-low transition of G

description

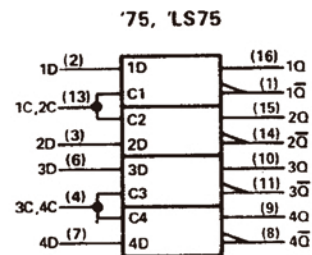
These latches are ideally suited for use as temporary storage for binary information between processing units and input/output or indicator units. Information present at a data (D) input is transferred to the Q output when the enable (C) is high and the Q output will follow the data input as long as the enable remains high. When the enable goes low, the information (that was present at the data input at the time the transition occurred) is retained at the Q output until the enable is permitted to go high.

The '75 and 'LS75 feature complementary Q and \bar{Q} outputs from a 4-bit latch, and are available in various 16-pin packages. For higher component density applications.

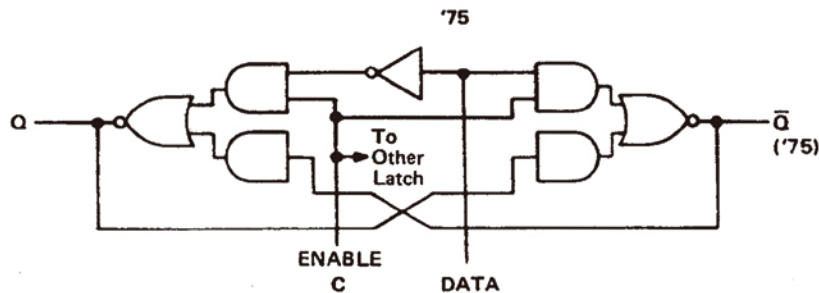
XD74LS75 0° C to 70° C.



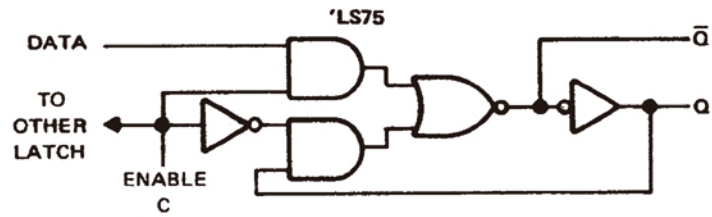
logic symbols†



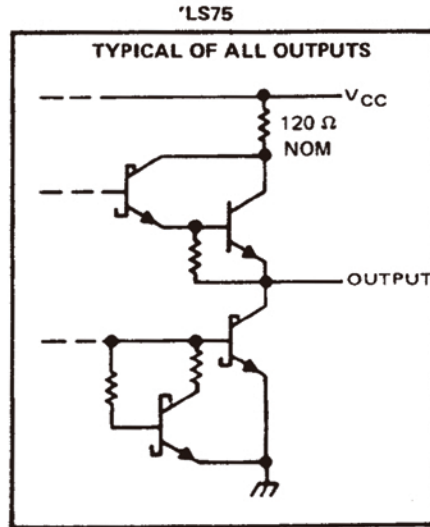
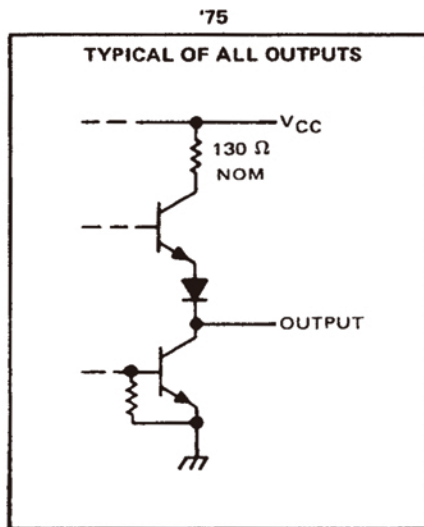
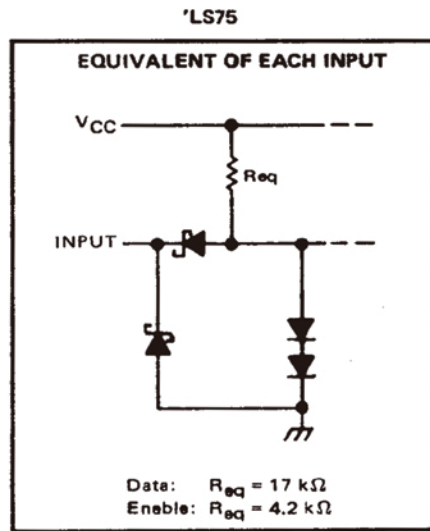
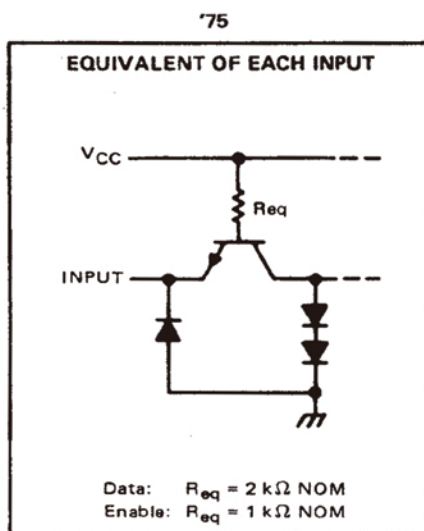
logic diagrams (each latch) (positive logic)



XD74LS75 DIP-16



schematics of inputs and outputs



XD74LS75 DIP-16

recommended operating conditions

	XD74LS75			UNIT
	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.75	5	5.25	V
High-level output current, I_{OH}			-400	μ A
Low-level output current, I_{OL}			16	mA
Width of enabling pulse, t_W	20			ns
Setup time, t_{SU}	20			ns
Hold time, t_H	5			ns
Operating free-air temperature, T_A	0		70	$^{\circ}$ C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	MIN	TYP‡	MAX	UNIT
V_{IH}	High-level input voltage		2			V
V_{IL}	Low-level input voltage				0.8	V
V_{IK}	Input clamp voltage	$V_{CC} = \text{MIN}, I_I = -12 \text{ mA}$			-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -400 \mu\text{A}$	2.4	3.4		V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 16 \text{ mA}$		0.2	0.4	V
I_I	Input current at maximum input voltage	$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1	mA
I_{IH}	High-level input current	D input	$V_{CC} = \text{MAX}, V_I = 2.4 \text{ V}$		80	μ A
		C input		160		
I_{IL}	Low-level input current	D input	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$		-3.2	mA
		C input		-6.4		
I_{OS}	Short-circuit output current§	$V_{CC} = \text{MAX}$	SN54'	-20	-57	mA
			SN74'	-18	-57	
I_{CC}	Supply current	$V_{CC} = \text{MAX},$ See Note 3	SN54'	32	46	mA
			SN74'	32	53	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$.

§ Not more than one output should be shorted at a time.

NOTE 3: I_{CC} is tested with all inputs grounded and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	D	Q	$C_L = 15 \text{ pF},$ $R_L = 400 \Omega,$ See Figure 1	16	30	ns	
t_{PHL}				14	25		
$t_{PLH}\ddagger$	D	\bar{Q}		24	40	ns	
$t_{PHL}\ddagger$				7	15		
t_{PLH}	C	Q		16	30	ns	
t_{PHL}				7	15		
$t_{PLH}\ddagger$	C	\bar{Q}		16	30	ns	
$t_{PHL}\ddagger$				7	15		

$t_{PLH} \equiv$ propagation delay time, low-to-high-level output

$t_{PHL} \equiv$ propagation delay time, high-to-low-level output

XD74LS75 DIP-16

recommended operating conditions

	XD74LS75			UNIT
	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.75	5	5.25	V
High-level output current, I_{OH}			-400	μA
Low-level output current, I_{OL}			8	mA
Width of enabling pulse, t_W	20			ns
Setup time, t_{SU}	20			ns
Hold time, t_H	5			ns
Operating free-air temperature, T_A	0		70	$^{\circ}C$

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	XD74LS75			UNIT
		MIN	TYP‡	MAX	
V_{IH} High-level input voltage		2			V
V_{IL} Low-level input voltage				0.8	V
V_{IK} Input clamp voltage	$V_{CC} = \text{MIN}, I_I = -18 \text{ mA}$			-1.5	V
V_{OH} High-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = V_{IL \text{ max}}, I_{OH} = -400 \mu A$	2.7	3.5		V
V_{OL} Low-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = V_{IL \text{ max}}$				V
I_I Input current at maximum input voltage	$V_{CC} = \text{MAX}, V_I = 7 \text{ V}$	$I_{OL} = 4 \text{ mA}$	0.25	0.4	mA
		$I_{OL} = 8 \text{ mA}$	0.35	0.5	
I_{IH} High-level input current	$V_{CC} = \text{MAX}, V_I = 2.7 \text{ V}$	D input		20	μA
		C input		80	
I_{IL} Low-level input current	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$	D input		-0.4	mA
		C input		-1.6	
I_{OS} Short-circuit output current §	$V_{CC} = \text{MAX}$	-20		-100	mA
I_{CC} Supply current	$V_{CC} = \text{MAX},$ See Note 2	'LS75	6.3	12	mA
		'LS77			

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}C$.

§ Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second

NOTE 2: I_{CC} is tested with all inputs grounded and all outputs open.

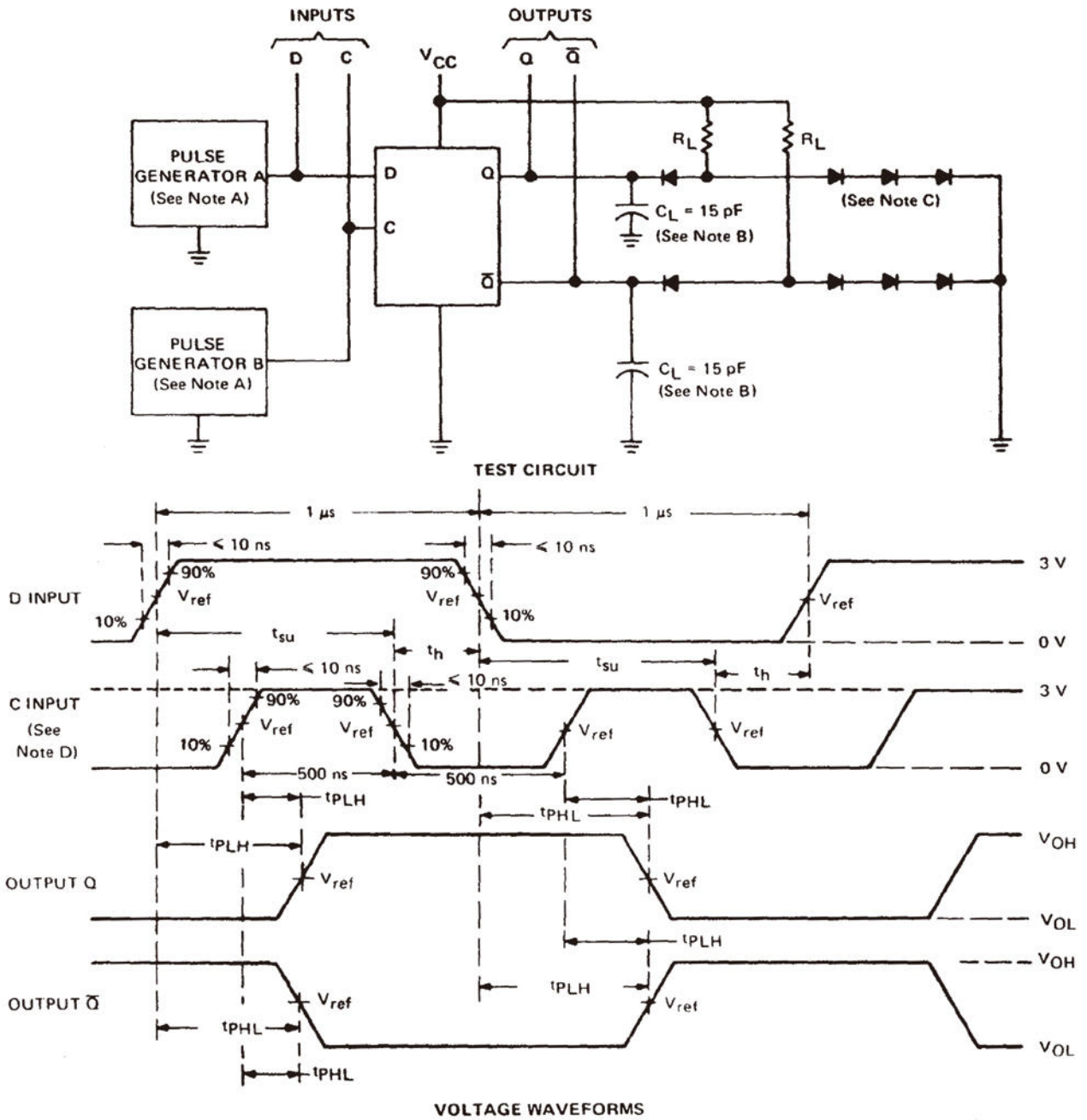
switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}C$

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS75			UNIT
				MIN	TYP	MAX	
t_{PLH}	D	Q	$C_L = 15 \text{ pF},$ $R_L = 2 \text{ k}\Omega,$ See Figure 1		15	27	ns
t_{PHL}					9	17	
t_{PLH}	D	\bar{Q}			12	20	ns
t_{PHL}					7	15	
t_{PLH}	C	Q			15	27	ns
t_{PHL}					14	25	
t_{PLH}	C	\bar{Q}			16	30	ns
t_{PHL}					7	15	

¶ t_{PLH} = propagation delay time, low-to-high-level output
 t_{PHL} = propagation delay time, high-to-low-level output

switching characteristics†

PARAMETER MEASUREMENT INFORMATION



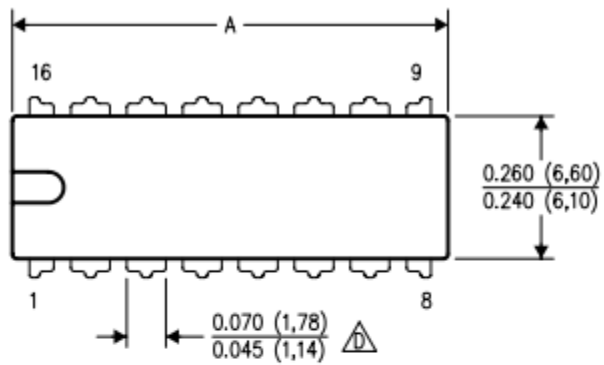
† Complementary Q outputs are on the '75 and 'LS75 only.

- NOTES: A. The pulse generators have the following characteristics: $Z_{out} \approx 50 \Omega$; for pulse generator A, $PRR \leq 500 \text{ kHz}$; for pulse generator B, $PRR \leq 1 \text{ MHz}$. Positions of D and C input pulses are varied with respect to each other to verify setup times.
- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N3064 or equivalent.
- D. When measuring propagation delay times from the D input, the corresponding C input must be held high.
- E. For '75, $V_{ref} = 1.5 \text{ V}$; for 'LS75, $V_{ref} = 1.3 \text{ V}$.

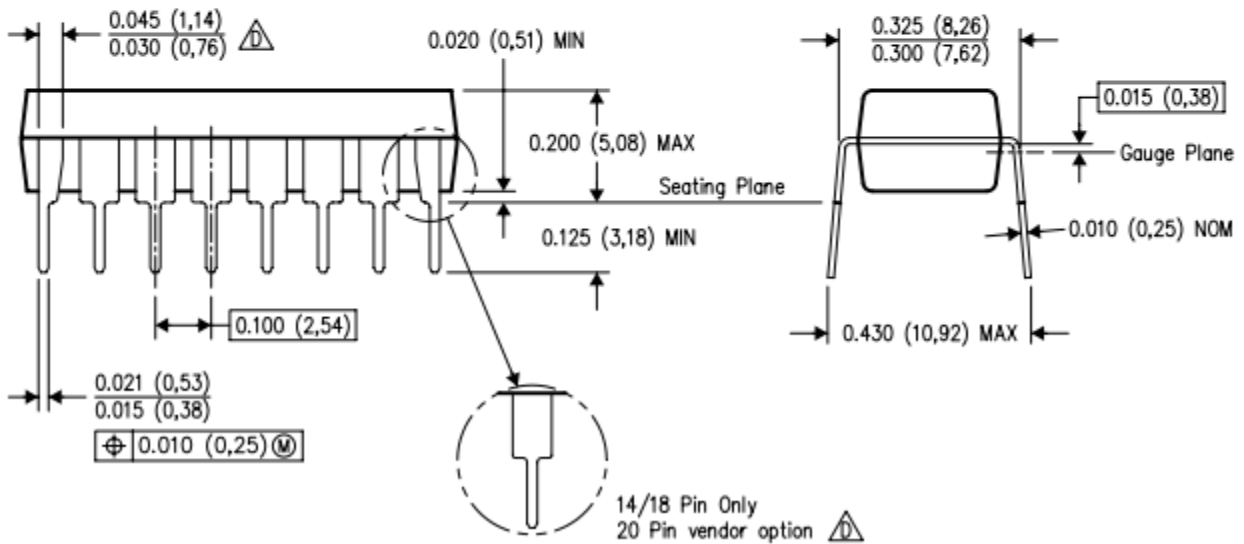
FIGURE 1

XD74LS75 DIP-16

DIP



DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



以上信息仅供参考. 如需帮助联系客服人员. 谢谢 XINLU DA

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